

## SANYO Semiconductors DATA SHEET

An ON Semiconductor Company

N-Channel Silicon MOSFET

# ATP404 — General-Purpose Switching Device Applications

## **Features**

- ON-resistance RDS(on)1=5.5m $\Omega$  (typ.)
- · 4.5V drive

- Input capacitance Ciss=6400pF (typ.)
- · Halogen free compliance

## **Specifications**

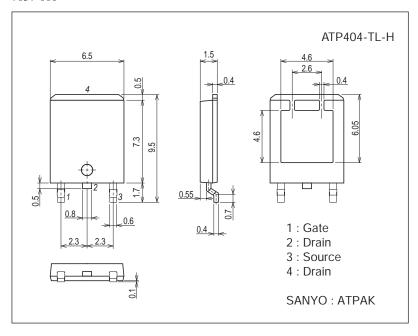
Absolute Maximum Ratings at Ta=25°C

Parameter	Symbol	Conditions	Ratings	Unit
Drain-to-Source Voltage	V <sub>DSS</sub>		60	V
Gate-to-Source Voltage	VGSS		±20	V
Drain Current (DC)	ID		95	Α
Drain Current (Pulse)	IDP	PW≤10μs, duty cycle≤1%	380	Α
Allowable Power Dissipation	PD	Tc=25°C	70	W
Channel Temperature	Tch		150	°C
Storage Temperature	Tstg		-55 to +150	°C
Avalanche Energy (Single Pulse) *1	EAS		214	mJ
Avalanche Current *2	IAV		48	Α

Note :\*1  $V_{DD}$ =30V, L=100 $\mu$ H, IAV=48A

## **Package Dimensions**

unit : mm (typ) 7057-001



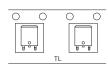
## **Product & Package Information**

• Package : ATPAK

• JEITA, JEDEC :-

• Minimum Packing Quantity : 3,000 pcs./reel

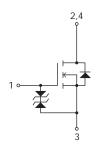
## Packing Type: TL



## Marking



### **Electrical Connection**

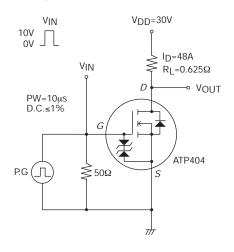


<sup>\*2</sup> L≤100μH, Single pulse

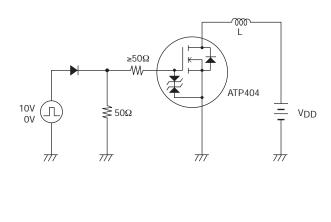
## Electrical Characteristics at Ta=25°C

Parameter	Symbol	Conditions	Ratings			Unit	
Parameter	Symbol	Conditions	min	typ	max	Uniii	
Drain-to-Source Breakdown Voltage	V(BR)DSS	ID=1mA, VGS=0V	60			V	
Zero-Gate Voltage Drain Current	IDSS	V <sub>DS</sub> =60V, V <sub>GS</sub> =0V			10	μΑ	
Gate-to-Source Leakage Current	IGSS	V <sub>GS</sub> =±16V, V <sub>DS</sub> =0V			±10	μΑ	
Cutoff Voltage	V <sub>GS</sub> (off)	V <sub>DS</sub> =10V, I <sub>D</sub> =1mA	1.2		2.6	V	
Forward Transfer Admittance	yfs	V <sub>DS</sub> =10V, I <sub>D</sub> =48A		100		S	
Static Drain-to-Source On-State Resistance	R <sub>DS</sub> (on)1	I <sub>D</sub> =48A, V <sub>GS</sub> =10V		5.5	7.2	mΩ	
	R <sub>DS</sub> (on)2	I <sub>D</sub> =48A, V <sub>G</sub> S=4.5V		7.5	10.5	mΩ	
Input Capacitance	Ciss			6400		pF	
Output Capacitance	Coss	V <sub>DS</sub> =20V, f=1MHz		490		pF	
Reverse Transfer Capacitance	Crss			380		pF	
Turn-ON Delay Time	t <sub>d</sub> (on)			53		ns	
Rise Time	t <sub>r</sub>	San appairing Test Circuit		640		ns	
Turn-OFF Delay Time	t <sub>d</sub> (off)	See specified Test Circuit.		380		ns	
Fall Time	tf			520		ns	
Total Gate Charge	Qg			120		nC	
Gate-to-Source Charge	Qgs	V <sub>DS</sub> =30V, V <sub>GS</sub> =10V, I <sub>D</sub> =95A		25		nC	
Gate-to-Drain "Miller" Charge	Qgd			25		nC	
Diode Forward Voltage	VSD	IS=95A, VGS=0V		0.95	1.2	V	

## Switching Time Test Circuit

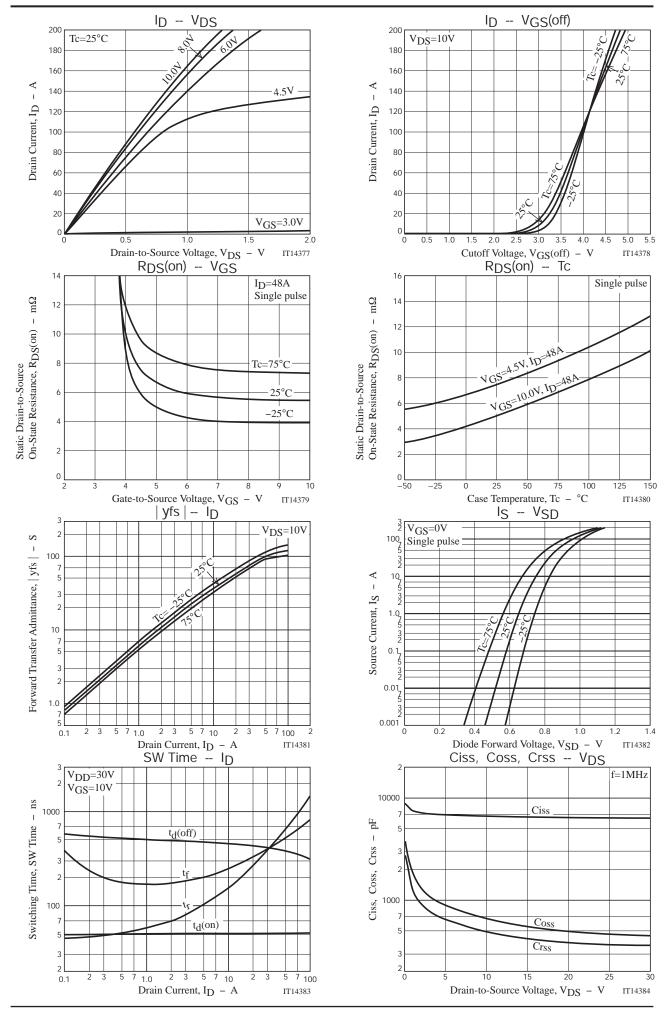


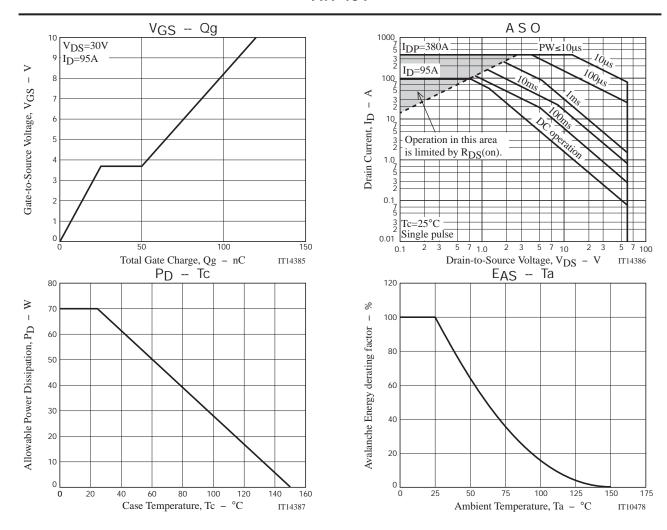
## **Avalanche Resistance Test Circuit**



## **Ordering Information**

Device	Package	Shipping	memo	
ATP404-TL-H	ATP404-TL-H ATPAK		Pb Free and Halogen Free	



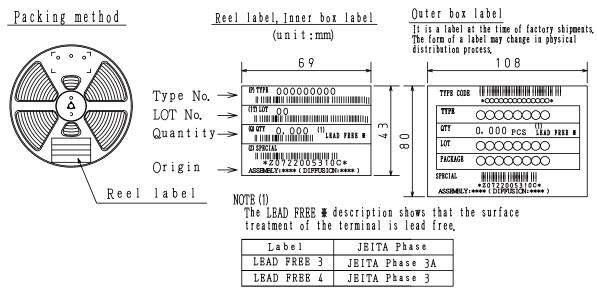


### **Taping Specification**

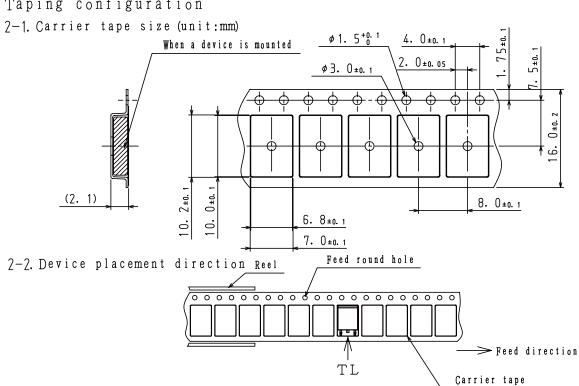
ATP404-TL-H

## 1. Packing Format (TL)

Package Name Carrier Tape Type		Maximum Number of devices contained (pcs)			Packing format		
		Reel	Inner box	Outer box	INNER BOX SD-C-18	OUTER BOX SD-A-18	
					1 reels contained	5 inner boxes contained	
ATPAK	ATPAK   ATP  3,000	3,000	00 3,000	15,000	Dimensions:mm (external)	Dimensions:mm (external)	
					340×340×28	355×355×165	



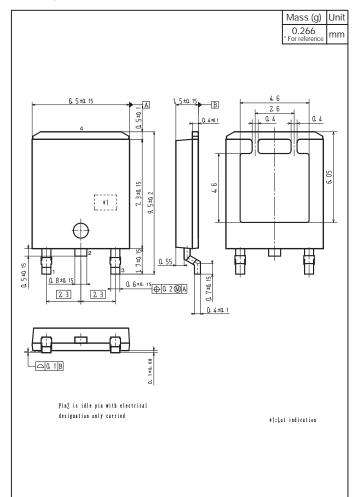
## 7. Taping configuration



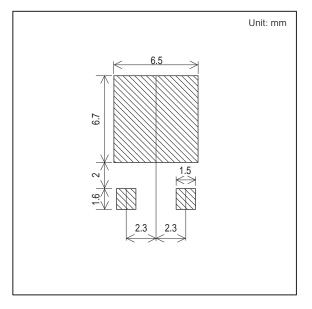
The one erectrode terminals on feed hole side····TL

## Outline Drawing

## ATP404-TL-H



## **Land Pattern Example**



Note on usage: Since the ATP404 is a MOSFET product, please avoid using this device in the vicinity of highly charged objects.

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